

N-Channel Enhancement Mode MOSFET

1. Product Information

Features

Advanced trench technology

Excellent $R_{DS(ON)}$

Low gate charge

Applications

Battery protection

Load switch

Uninterruptible power supply

Quick reference

$V_{DS} = 60V$

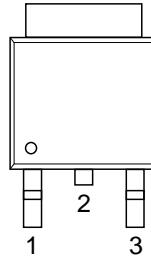
$I_D = 50A$

$R_{DS(ON)} \leq 16m\Omega @ V_{GS} = 10V$ (Type:11m Ω)

Pin Description

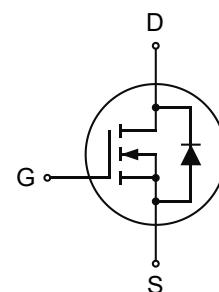
Pin	Description
1	Gate(G)
2	Drain(D)
3	Source(S)

Simplified Outline



Top View
TO-252

Symbol



Package Marking and Ordering Information

Product Name	Package	Marking	Reel size	Tape width	Quantity (pcs)
KJ50N06K	TO-252	50N06 XXXXXX	13"	24 mm	2500

2. Absolute Maximum Ratings ($T_c=25^\circ C$ unless otherwise noted)

Symbol	Parameter	Rating	Units
V_{DS}	Drain-Source Voltage	60	V
V_{GS}	Gate-Source Voltage	± 20	V
$I_D @ T_c=25^\circ C$	Continuous Drain Current, $V_{GS} @ 10V$ ¹	50	A
$I_D @ T_c=100^\circ C$	Continuous Drain Current, $V_{GS} @ 10V$ ¹	32	A
I_{DM}	Pulsed Drain Current ²	150	A
E_{AS}	Single Pulse Avalanche Energy ³	72	mJ
I_{AS}	Avalanche Current	38	A
$P_D @ T_c=25^\circ C$	Total Power Dissipation ⁴	45	W
T_J, T_{stg}	Operating Junction and Storage Temperature	-55 to 150	°C
$R_{\theta JA}$	Thermal Resistance Junction-Ambient ¹	62	°C/W
$R_{\theta JC}$	Thermal Resistance Junction-Case ¹	2.8	°C/W

3. Electrical Characteristics ($T_J=25^\circ\text{C}$, unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
BV_{DSS}	Drain-Source Breakdown Voltage	$V_{\text{GS}}=0\text{V}, I_{\text{D}}=250\mu\text{A}$	60	65	-	V
$\Delta \text{BV}_{\text{DSS}}/\Delta T_J$	BV_{DSS} Temperature Coefficient	Reference to 25°C , $I_{\text{D}}=1\text{mA}$	-	0.057	-	$\text{V}/^\circ\text{C}$
$R_{\text{DS}(\text{ON})}$	Static Drain-Source On-Resistance ²	$V_{\text{GS}}=10\text{V}, I_{\text{D}}=20\text{A}$	-	11	16	$\text{m}\Omega$
		$V_{\text{GS}}=4.5\text{V}, I_{\text{D}}=10\text{A}$	-	16	20	
$V_{\text{GS}(\text{th})}$	Gate Threshold Voltage	$V_{\text{GS}}=V_{\text{DS}}, I_{\text{D}}=250\mu\text{A}$	1.2	1.8	2.5	V
$\Delta V_{\text{GS}(\text{th})}$	$V_{\text{GS}(\text{th})}$ Temperature Coefficient		-	-5.68	-	$\text{mV}/^\circ\text{C}$
I_{DSS}	Drain-Source Leakage Current	$V_{\text{DS}}=48\text{V}, V_{\text{GS}}=0\text{V}, T_J=25^\circ\text{C}$	-	-	1	μA
			-	-	5	
I_{GSS}	Gate-Source Leakage Current	$V_{\text{GS}}=\pm 20\text{V}, V_{\text{DS}}=0\text{V}$	-	-	± 100	nA
g_{fs}	Forward Transconductance	$V_{\text{DS}}=5\text{V}, I_{\text{D}}=15\text{A}$	-	45	-	S
R_g	Gate Resistance	$V_{\text{DS}}=0\text{V}, V_{\text{GS}}=0\text{V}, f=1\text{MHz}$	-	1.7	-	Ω
Q_g	Total Gate Charge (4.5V)	$V_{\text{DS}}=48\text{V}$ $V_{\text{GS}}=4.5\text{V}$ $I_{\text{D}}=30\text{A}$	-	19.3	-	nC
Q_{gs}	Gate-Source Charge		-	7.1	-	
Q_{gd}	Gate-Drain Charge		-	7.6	-	
$t_{\text{d}(\text{on})}$	Turn-On Delay Time	$V_{\text{DD}}=30\text{V}, V_{\text{GS}}=10\text{V}$ $R_G=3.3\Omega, I_{\text{D}}=15\text{A}$	-	7.2	-	ns
t_r	Rise Time		-	50	-	
$t_{\text{d}(\text{off})}$	Turn-Off Delay Time		-	36.4	-	
t_f	Fall Time		-	7.6	-	
C_{iss}	Input Capacitance	$V_{\text{DS}}=15\text{V}, V_{\text{GS}}=0\text{V}, f=1\text{MHz}$	-	2423	-	pF
C_{oss}	Output Capacitance		-	145	-	
C_{rss}	Reverse Transfer Capacitance		-	97	-	
I_s	Continuous Source Current ^{1,5}	$V_{\text{GS}}=V_{\text{DS}}=0\text{V}$, Force Current	-	-	35	A
I_{SM}	Pulsed Source Current ^{2,5}		-	-	80	A
V_{SD}	Diode Forward Voltage ²	$V_{\text{GS}}=0\text{V}, I_{\text{S}}=1\text{A}, T_J=25^\circ\text{C}$	-	-	1	V
t_{rr}	Reverse Recovery Time	$I_{\text{F}}=15\text{A},$ $dI/dt=100\text{A}/\mu\text{s},$ $T_J=25^\circ\text{C}$	-	16.3	-	ns
		-	11	-	nC	

Note:

1. The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper.
2. The data tested by pulsed , pulse width $\leq 300\mu\text{s}$, duty cycle $\leq 2\%$.
3. The E_{AS} data shows Max. rating. The test condition is $V_{\text{DD}}=30\text{V}, V_{\text{GS}}=10\text{V}, L=0.5\text{mH}, I_{\text{AS}}=38\text{A}$.
4. The power dissipation is limited by 150°C junction temperature.
5. The data is theoretically the same as I_{D} and I_{DM} , in real applications, should be limited by total power dissipation.

4. Typical Characteristics

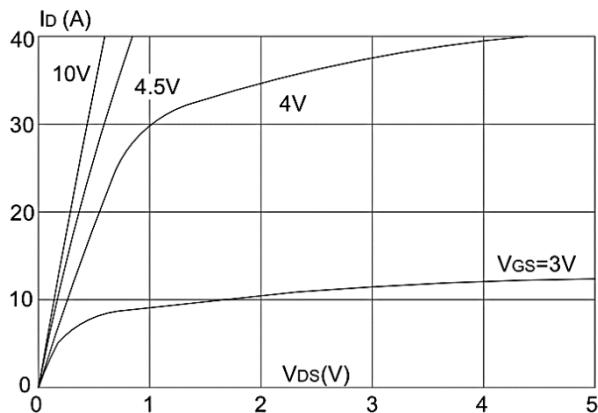


Figure 1: Output Characteristics

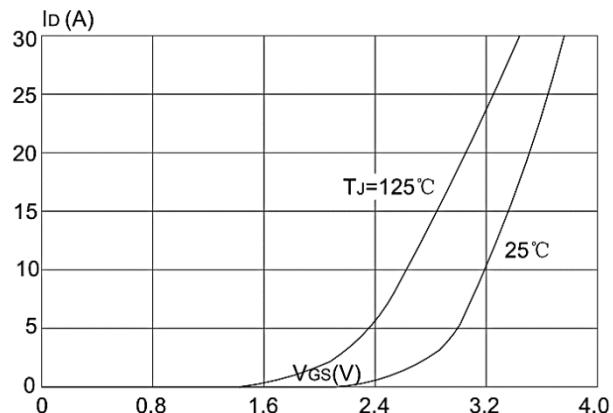


Figure 2: Typical Transfer Characteristics

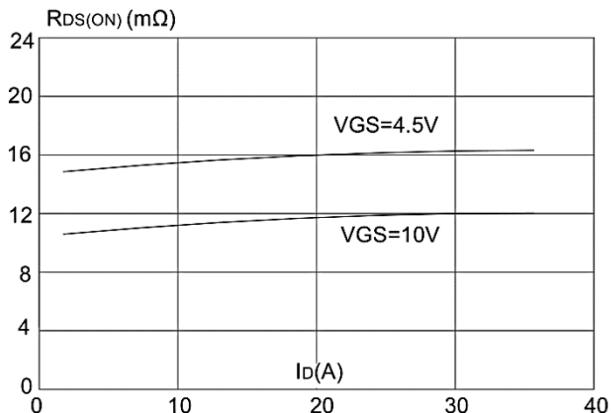


Figure 3: On-resistance vs. Drain Current

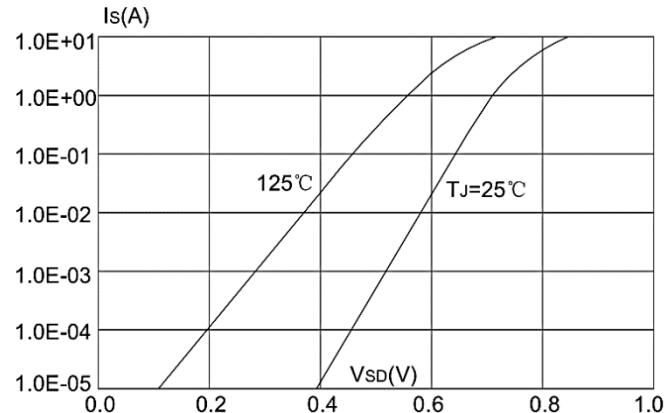


Figure 4: Body Diode Characteristics

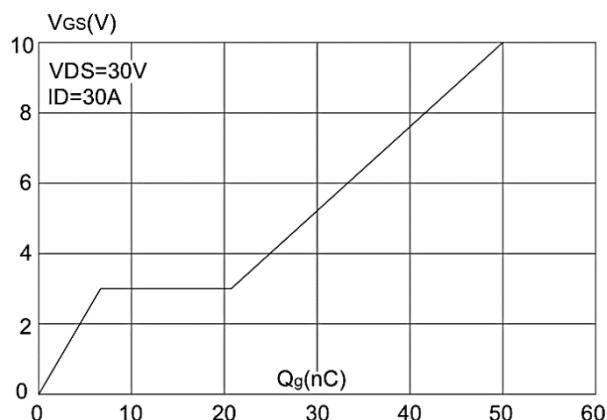


Figure 5: Gate Charge Characteristics

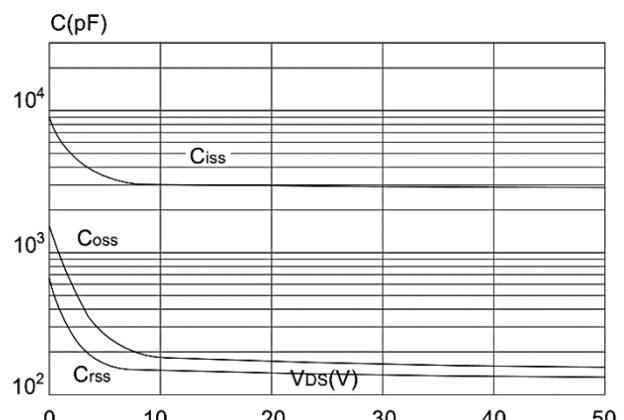


Figure 6: Capacitance Characteristics

4. Typical Characteristics (cont.)

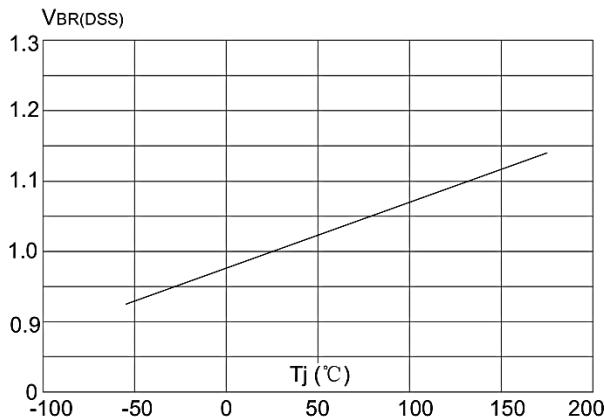


Figure 7: Normalized Breakdown Voltage vs Junction Temperature

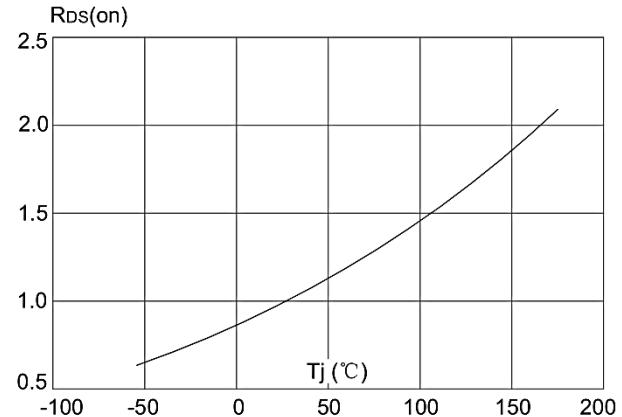


Figure 8: Normalized on Resistance vs. Junction Temperature

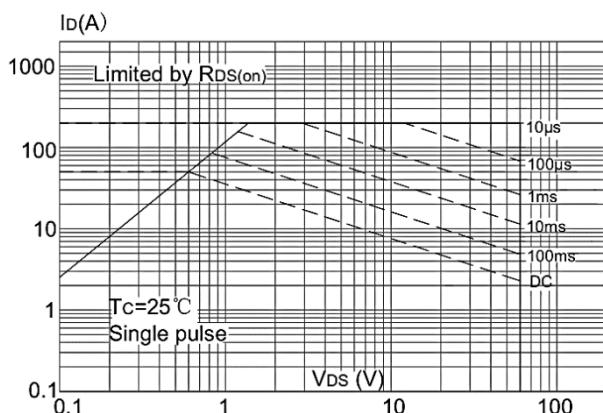


Figure 9: Maximum Safe Operating Area

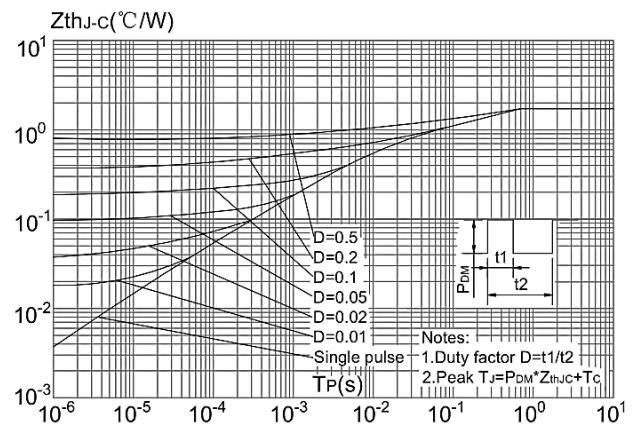


Figure 10: Maximum Effective Transient Thermal Impedance, Junction-to-Ambient

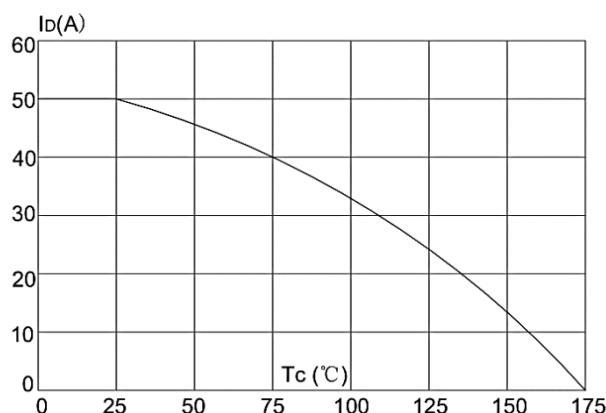
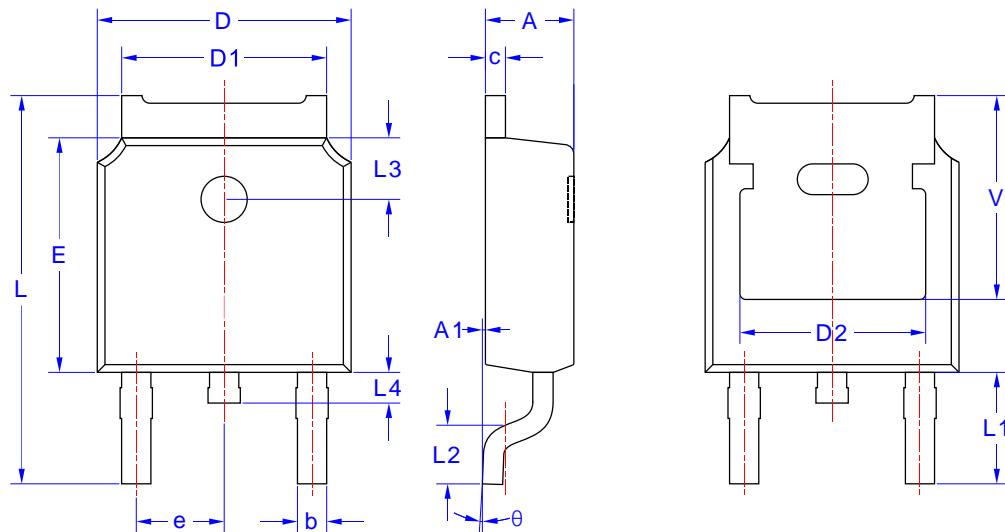


Figure 11: Maximum Continuous Drain Current vs. Ambient Temperature

5. Package Mechanical Data

TO-252 Package



Symbol	Dimensions in Millimeters	
	MIN	MAX
A	2.200	2.400
A1	0	0.127
b	0.660	0.860
c	0.460	0.580
D	6.500	6.700
D1	5.100	5.460
D2	4.830 REF.	
E	6.000	6.200
e	2.186	2.386
L	9.800	10.400
L1	2.900 REF.	
L2	1.400	1.700
L3	1.800 REF.	
L4	0.600	1.000
θ	0°	8°
V	5.600 REF.	